

Enhancement Mode N-Channel Power MOSFET

PDFN5x6/NMOS/20V/ \pm 12V/0.9V/180A/2.5m Ω

Rev0.6





20V, 2.5mΩ, 180A, Single N-Channel

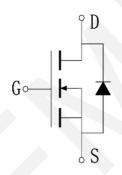
1.Features

- ◆ 20V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±10V

- ◆ Power Switching Application
- Load Switching



V _{DS}	R _{DS(on)} Typ.	I _D Max.	
20V	2.5mΩ @ 4.5V	4004	
	3.2mΩ @ 2.5V	180A	



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP20H80APA	WP20H80A	PDFN5X6	5,000	50,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units		
Drain to Source Voltage	$V_{ extsf{DSS}}$	20	V		
Gate to Source Voltage	V_{GSS}	±12	V		
Drain Current (DC)	I _D	180	Α		
Drain Current (Pulse), PW≤300µs	I _{DP}	720	А		
Total Dissipation	P _D	143	W		
Avalanche Energy, Single Pulsed	E _{AS}	182	mJ		
Junction Temperature	Tj	175	°C		
Storage Temperature	T _{stg}	-55 to +175	°C		

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	$R_{ heta JC}$	1.05	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

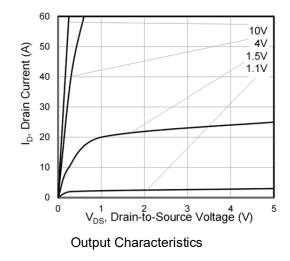
6.Electrical Characteristics at Ta=25°C (Note 3)

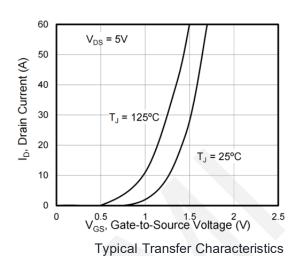
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	20	23.5	-	٧
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} =20V, V _{GS} = 0V	-	-	1	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	ı	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	0.5	0.9	1.2	V
Static Drain to Source On-State	В	$I_D = 30A, V_{GS} = 4.5V$	1	2.5	2.8	mΩ
Resistance	R _{DS(on)}	$I_D = 20A, V_{GS} = 2.5V$	-	3.2	4	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,	-	11050	-	pF
Output Capacitance	C _{oss}	V _{DS} =10V,	-	1749	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	1	1575	-	pF
Turn-ON Delay Time	t _{d(on)}		ı	21	-	ns
Rise Time	t _r	$V_{DD} = 10V, I_D = 50A,$	-	28	-	ns
Turn-OFF Delay Time	$t_{d(off)}$	$R_{GEN} = 3\Omega$	-	31	-	ns
Fall Time	t _f		-	25	-	ns
	Q_g	V _{DD} = 10V, V _{GS} = 10V,	-	270	-	nC
Total Gate Charge	Q _{gs}		-	15	-	nC
	Q_{gd}	I _D = 50A	-	50	-	nC
Diode Forward Voltage	V_{FSD}	I _S =30A, V _{GS} = 0	0.4	0.8	1.2	V

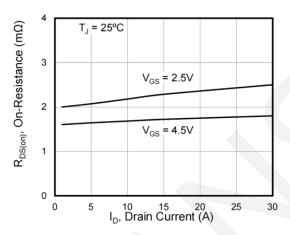
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

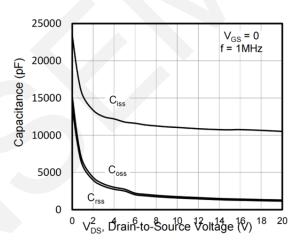


7. Typical electrical and thermal characteristics



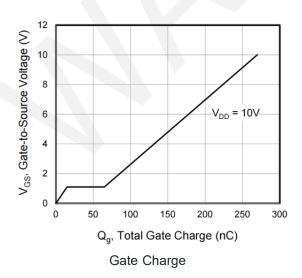


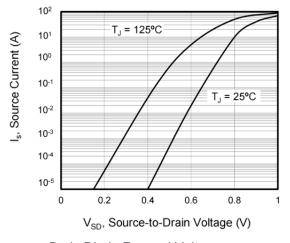




On-resistance vs. Drain Current

Capacitance

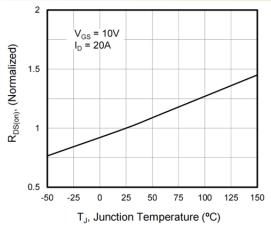


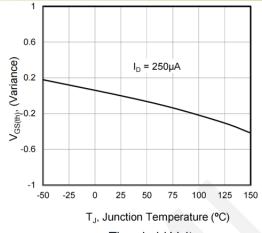


Body Diode Forward Voltage







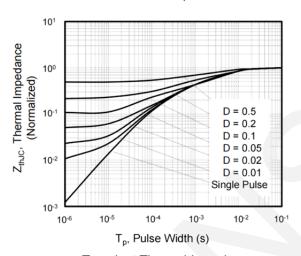


On-Resistance vs.

Threshold Voltage vs.

Junction Temperature

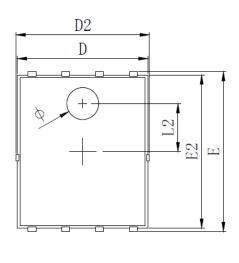
Junction Temperature

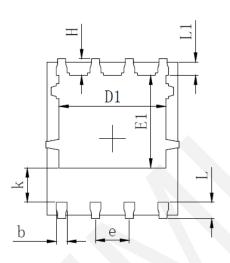


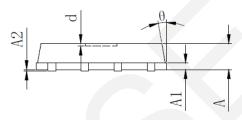
Transient Thermal Impedance



8.Package Dimensions







SYMBOL		MILLIMETER			
	MIN	Typ.	MAX		
A	0. 900	1. 000	1. 100		
A1		0. 254 REF.			
A2		0~0.05			
D	4. 824	4. 824 4. 900 4. 97			
D1	3. 910	4. 010	4. 110		
D2	4. 924	5. 000	5. 076		
Е	5. 924	6. 000	6.076		
E1	3. 375	3. 475	3. 575		
E2	5. 674	5. 750	5.826		
b	0. 350	0. 400	0.450		
е	1.270 TYP.				
L	0. 534	0. 610	0. 686		
L1	0. 424	0. 500	0. 576		
L2	1.800 REF.				
k	1. 190	1. 290	1.390		
Н	0. 549	0. 625	0.701		
θ	8°	10°	12°		
ф	1. 100	1. 200	1. 300		
d			0. 100		



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